

International  
**IR** Rectifier

**SMPS MOSFET**

### Applications

- High frequency DC-DC converters
- UPS and Motor Control
- Lead-Free

PD - 95433

**IRF8010SPbF**

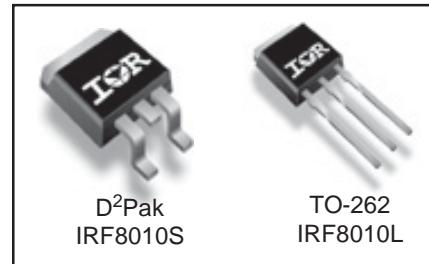
**IRF8010LPbF**

HEXFET® Power MOSFET

<b>V<sub>DSS</sub></b>	<b>R<sub>DS(on)</sub> max</b>	<b>I<sub>D</sub></b>
100V	15mΩ	80A <sup>⑦</sup>

### Benefits

- Low Gate-to-Drain Charge to Reduce Switching Losses
- Fully Characterized Capacitance Including Effective C<sub>oss</sub> to Simplify Design, (See App. Note AN1001)
- Fully Characterized Avalanche Voltage and Current
- Typical R<sub>DS(on)</sub> = 12mΩ



### Absolute Maximum Ratings

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	80 <sup>⑦</sup>	A
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	57	
I <sub>DM</sub>	Pulsed Drain Current ①	320	
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Power Dissipation	260	W
	Linear Derating Factor	1.8	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
dv/dt	Peak Diode Recovery dv/dt ②	16	V/ns
T <sub>J</sub>	Operating Junction and	-55 to + 175	°C
T <sub>STG</sub>	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	

### Thermal Resistance

	Parameter	Typ.	Max.	Units
R <sub>θJC</sub>	Junction-to-Case	—	0.57	°C/W
R <sub>θJC</sub>	Junction-to-Case (end of life) ③	—	0.80	
R <sub>θCS</sub>	Case-to-Sink, Flat, Greased Surface	0.50	—	
R <sub>θJA</sub>	Junction-to-Ambient (PCB Mount, steady state) ④	—	40	

Notes ① through ④ are on page 8

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06/21/04

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## Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	100	—	—	V	$V_{GS} = 0V, I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.11	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	—	12	15	m $\Omega$	$V_{GS} = 10V, I_D = 45\text{A}$ ④
$V_{GS(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	20	$\mu\text{A}$	$V_{DS} = 100V, V_{GS} = 0V$
		—	—	250		$V_{DS} = 100V, V_{GS} = 0V, T_J = 125^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	200	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage	—	—	-200		$V_{GS} = -20V$

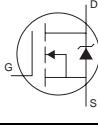
## Dynamic @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

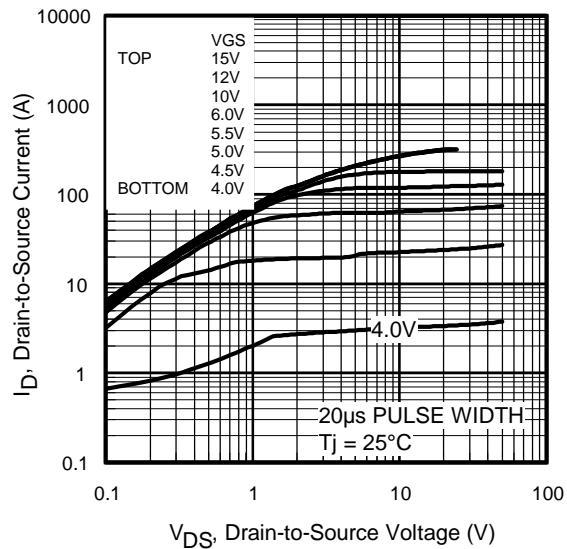
	Parameter	Min.	Typ.	Max.	Units	Conditions
$g_{fs}$	Forward Transconductance	82	—	—	V	$V_{DS} = 25V, I_D = 45\text{A}$
$Q_g$	Total Gate Charge	—	81	120	nC	$I_D = 80\text{A}$
$Q_{gs}$	Gate-to-Source Charge	—	22	—		$V_{DS} = 80V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	26	—		$V_{GS} = 10V$ ④
$t_{d(on)}$	Turn-On Delay Time	—	15	—	ns	$V_{DD} = 50V$
$t_r$	Rise Time	—	130	—		$I_D = 80\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	61	—		$R_G = 39\Omega$
$t_f$	Fall Time	—	120	—		$V_{GS} = 10V$ ④
$C_{iss}$	Input Capacitance	—	3830	—	pF	$V_{GS} = 0V$
$C_{oss}$	Output Capacitance	—	480	—		$V_{DS} = 25V$
$C_{rss}$	Reverse Transfer Capacitance	—	59	—		$f = 1.0\text{MHz}$
$C_{oss}$	Output Capacitance	—	3830	—		$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0\text{MHz}$
$C_{oss}$	Output Capacitance	—	280	—		$V_{GS} = 0V, V_{DS} = 80V, f = 1.0\text{MHz}$
$C_{oss \text{ eff.}}$	Effective Output Capacitance	—	530	—		$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V$ ③

## Avalanche Characteristics

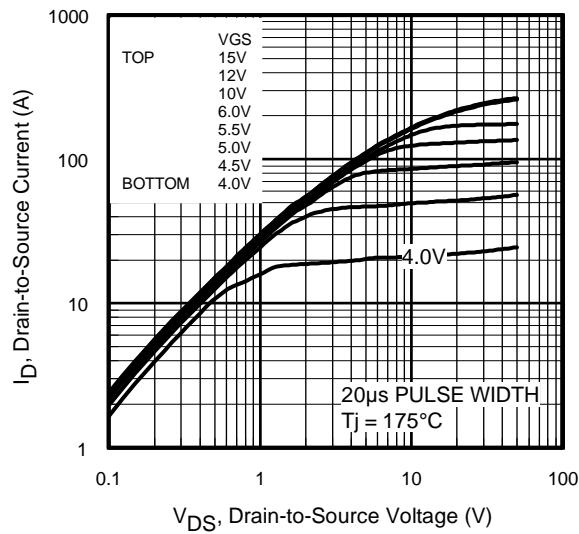
	Parameter	Typ.	Max.	Units
$E_{AS}$	Single Pulse Avalanche Energy ②⑦	—	310	mJ
$I_{AR}$	Avalanche Current ①	—	45	A
$E_{AR}$	Repetitive Avalanche Energy ①	—	26	mJ

## Diode Characteristics

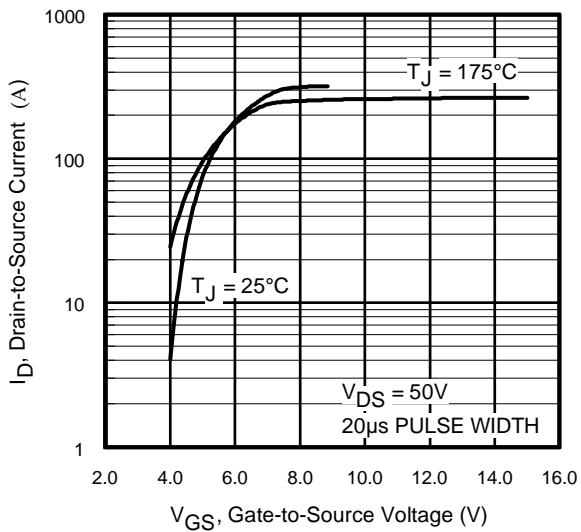
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	80	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{SM}$	Pulsed Source Current (Body Diode) ①⑦	—	—	320		
$V_{SD}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_S = 80\text{A}, V_{GS} = 0V$ ④
$t_{rr}$	Reverse Recovery Time	—	99	150	ns	$T_J = 150^\circ\text{C}, I_F = 80\text{A}, V_{DD} = 50V$
$Q_{rr}$	Reverse Recovery Charge	—	460	700	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ④
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				



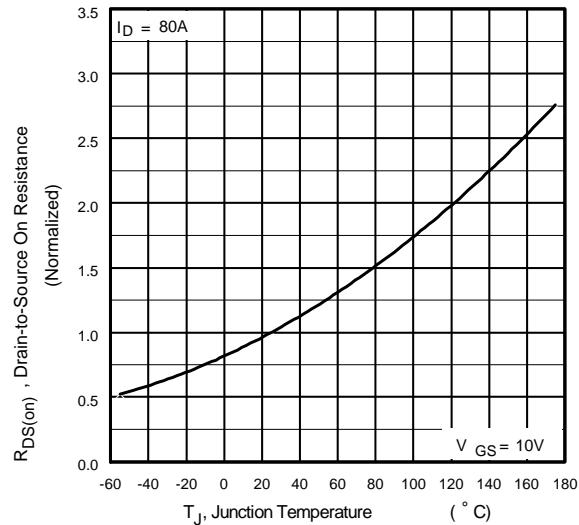
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



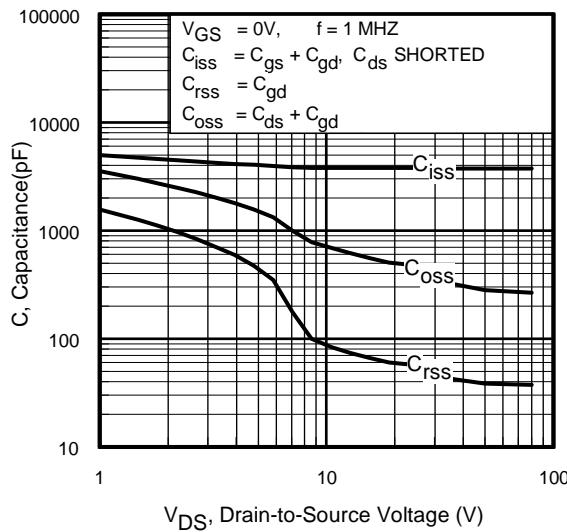
**Fig 3.** Typical Transfer Characteristics



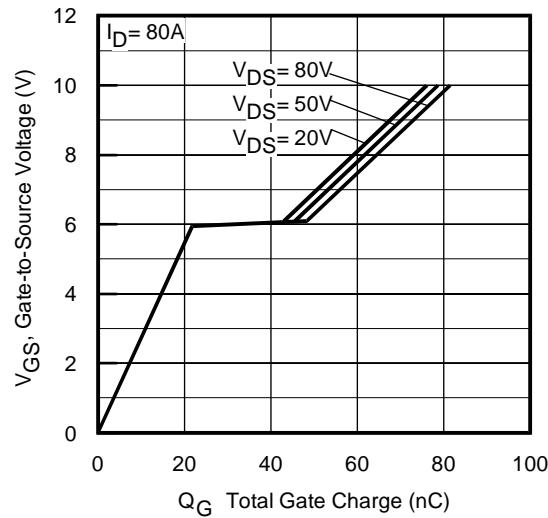
**Fig 4.** Normalized On-Resistance Vs. Temperature

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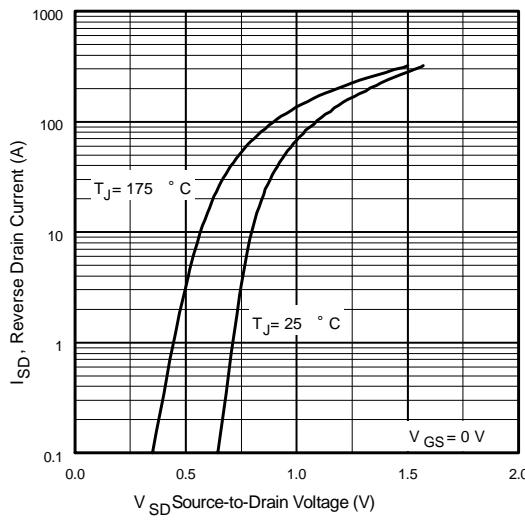
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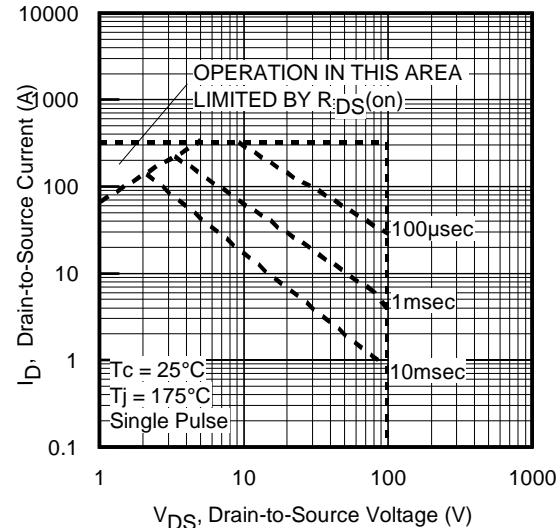
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



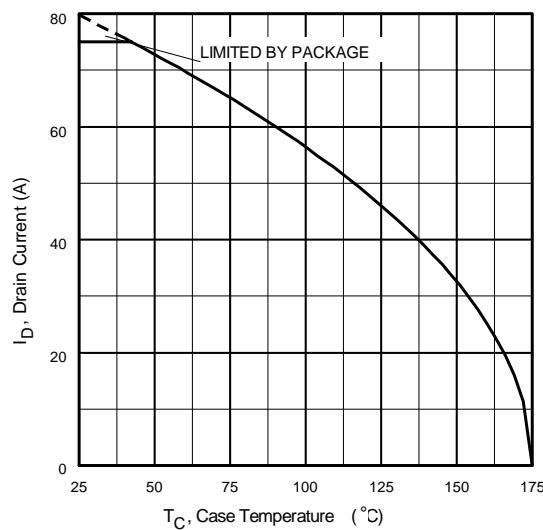
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



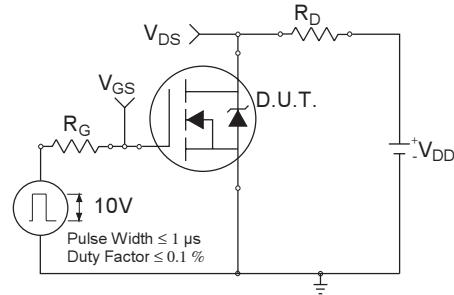
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



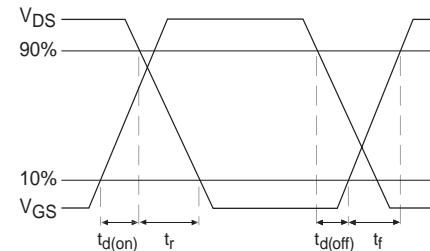
**Fig 8.** Maximum Safe Operating Area



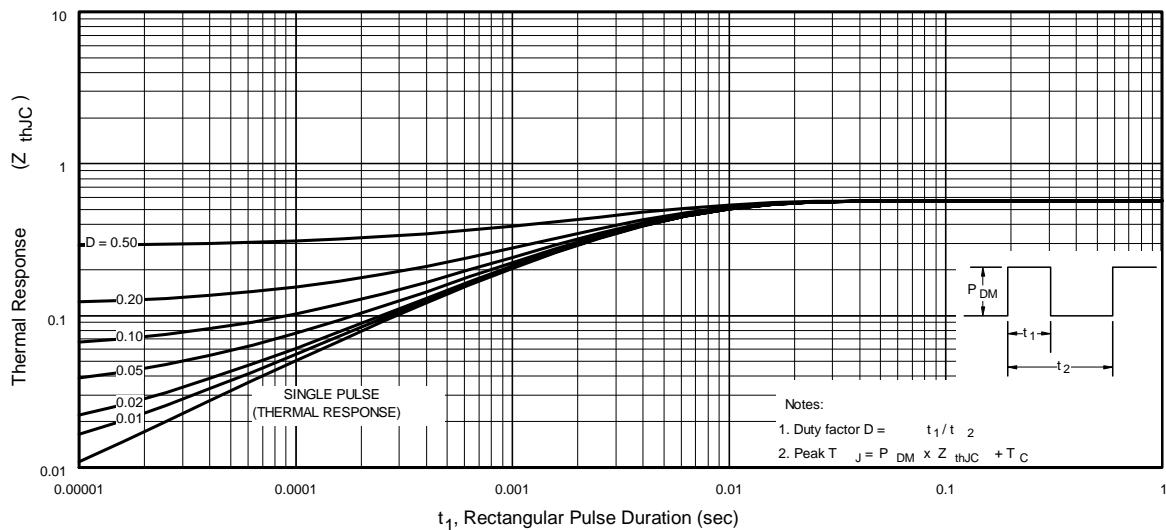
**Fig 9.** Maximum Drain Current Vs.  
Case Temperature



**Fig 10a.** Switching Time Test Circuit



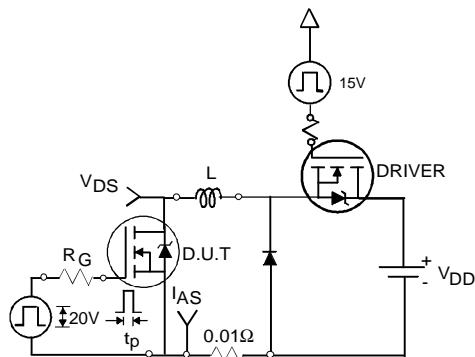
**Fig 10b.** Switching Time Waveforms



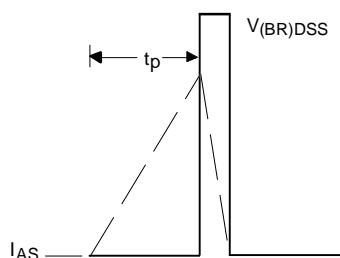
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

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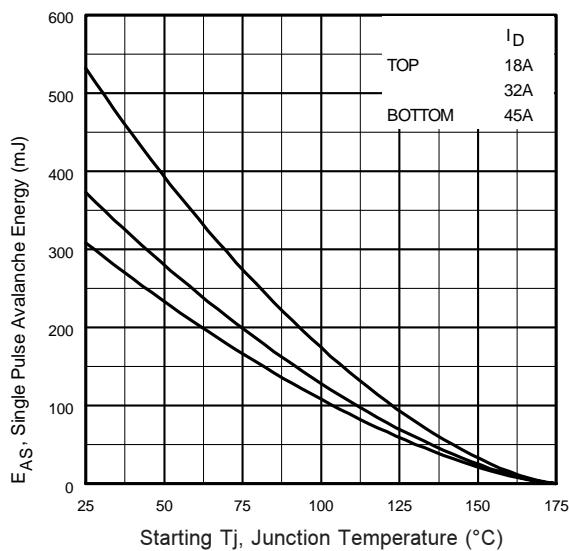
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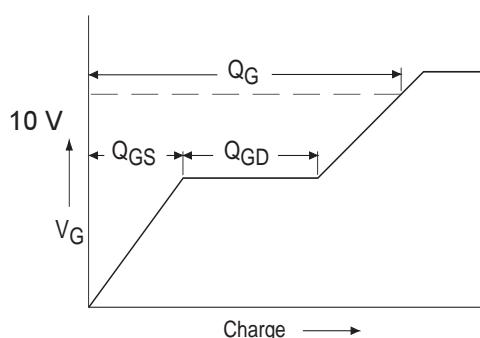
**Fig 12a.** Unclamped Inductive Test Circuit



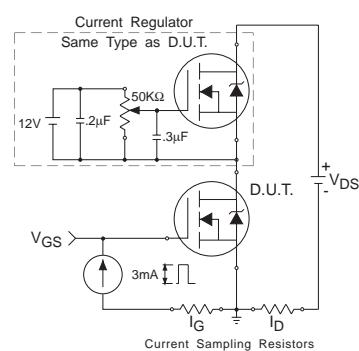
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

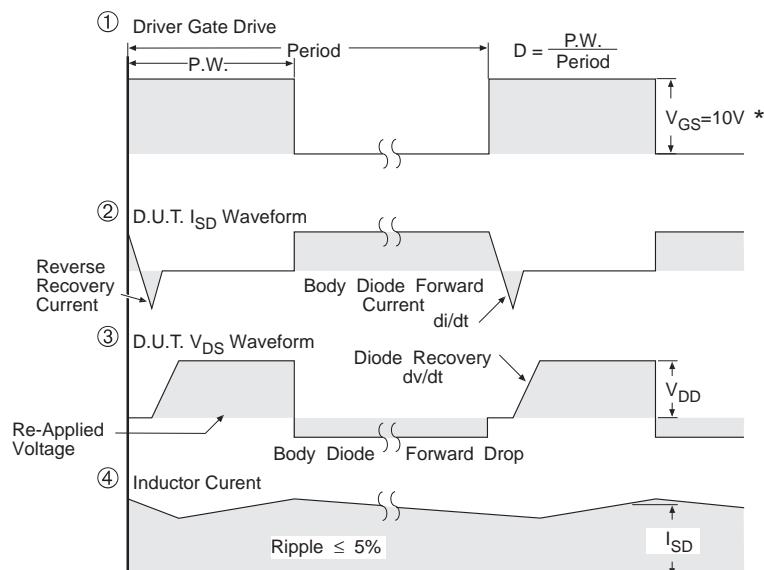
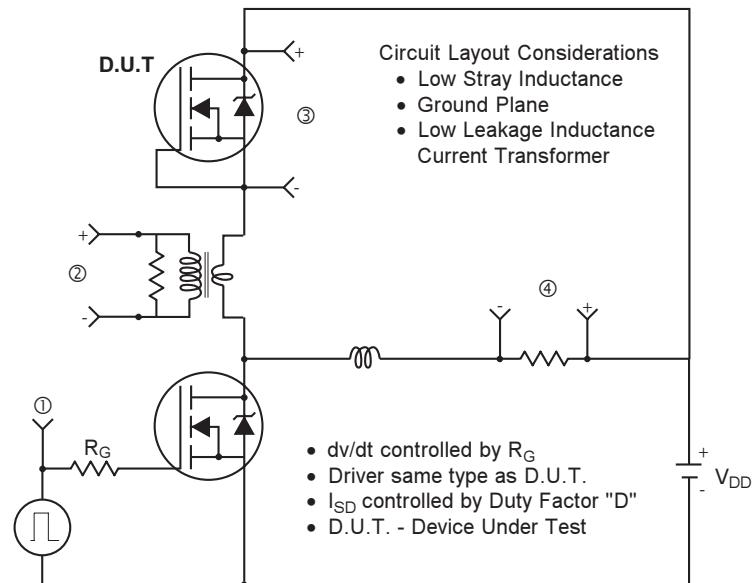


**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit

### Peak Diode Recovery dv/dt Test Circuit



\*  $V_{GS} = 5V$  for Logic Level Devices

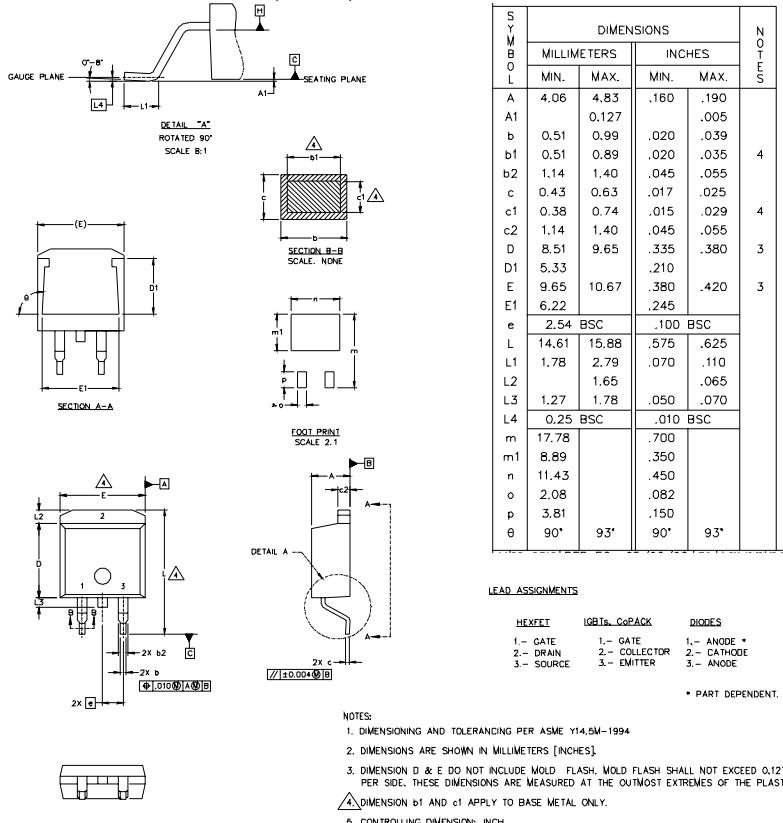
**Fig 14.** For N-Channel HEXFET® Power MOSFETs

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## D<sup>2</sup>Pak Package Outline

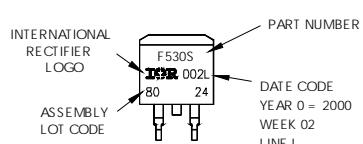
Dimensions are shown in millimeters (inches)



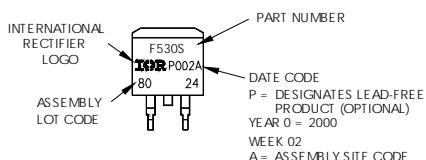
## D<sup>2</sup>Pak Part Marking Information

EXAMPLE: THIS IS AN IRF530S WITH  
LOT CODE 8024  
ASSEMBLED ON WW02, 2000  
IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line  
position indicates "Lead-Free"

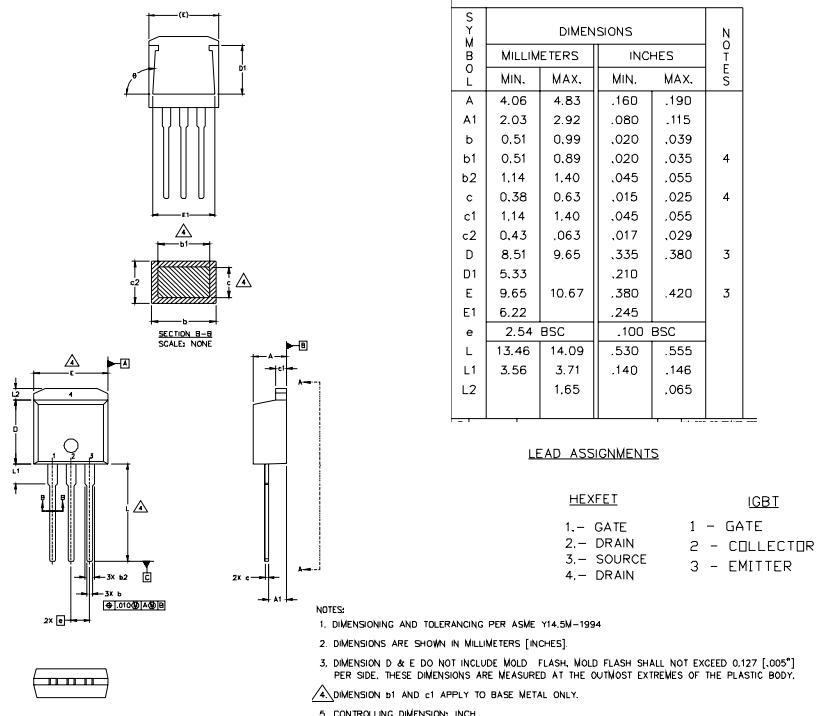


OR



## TO-262 Package Outline

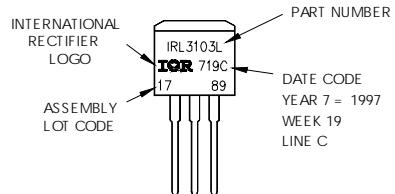
Dimensions are shown in millimeters (inches)



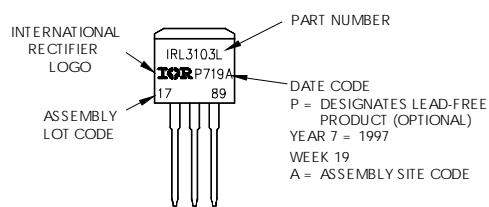
## TO-262 Part Marking Information

EXAMPLE: THIS IS AN IRL3103L  
LOT CODE 1789  
ASSEMBLED ON WW 19, 1997  
IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead-Free"



OR

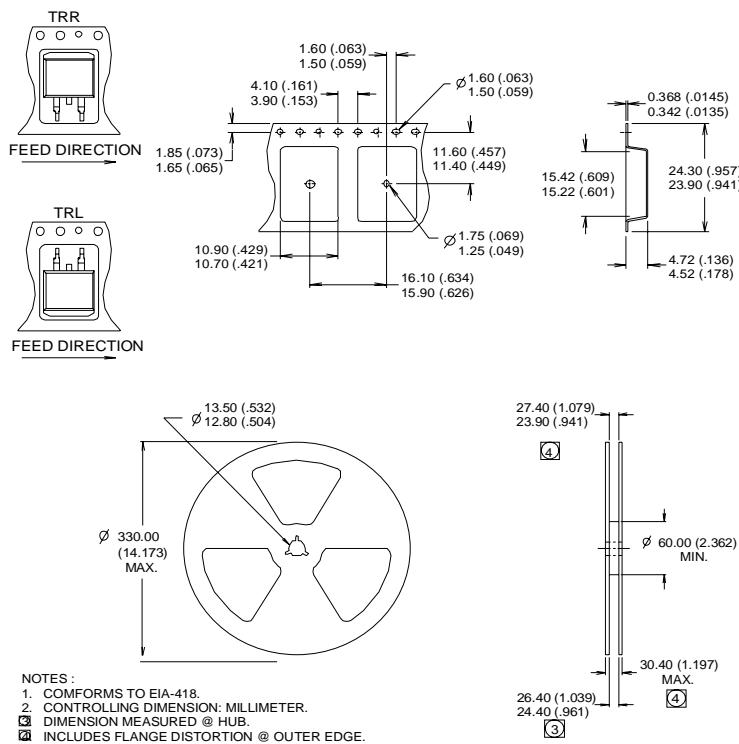


# IRF8010S/LPbF

## D<sup>2</sup>Pak Tape & Reel Information

Dimensions are shown in millimeters (inches)

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NOTES:  
 1. COMFORMS TO EIA-418.  
 2. CONTROLLING DIMENSION: MILLIMETER.  
 3. DIMENSION MEASURED @ HUB.  
 4. INCLUDES FLANGE DISTORTION @ OUTER EDGE.

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.31\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 45\text{A}$ .
- ③  $I_{SD} \leq 45\text{A}$ ,  $\text{di}/\text{dt} \leq 110\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 175^\circ\text{C}$ .
- ④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑤  $R_{th(jc)}$  (end of life) is the maximum measured value after 1000 temperature cycles from  $-55$  to  $150^\circ\text{C}$  and is accounted for by the physical wearout of the die attach medium in worse case PCB mounting condition of material (solder/substrate), process and re-flow temperature.
- ⑥  $C_{oss\ eff.}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑦ Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 75A.
- ⑧ When mounted on 1" square PCB ( FR-4 or G-10 Material ). For recommended footprint and soldering techniques refer to application note #AN-994.

Data and specifications subject to change without notice.  
 This product has been designed and qualified for the Industrial market.  
 Qualification Standards can be found on IR's Web site.

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Note: For the most current drawings please refer to the IR website at:  
<http://www.irf.com/package/>